

AUIRLR3110Z AUIRLU3110Z

HEXFET[®] Power MOSFET

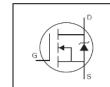
42A

Features

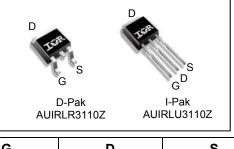
- Advanced Process Technology
- Ultra Low On-Resistance
- Logic Level Gate Drive
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



| V _{DSS} | | 100V |
|---------------------|--------|------|
| R _{DS(on)} | typ. | 11mΩ |
| | max. | 14mΩ |
| L (Silicon Lir | nited) | 63A9 |



D (Package Limited)

| G | D | S |
|------|-------|--------|
| Gate | Drain | Source |

| Base nort number Deckage Tune | | Standard Pack | | Orderable Part Number | |
|-------------------------------|--------------|--------------------|----------|-----------------------|--|
| Base part number | Package Type | Form | Quantity | Orderable Fart Number | |
| AUIRLU3110Z | I-Pak | Tube | 75 | AUIRLU3110Z | |
| | | Tube | 75 | AUIRLR3110Z | |
| AUIRLR3110Z | D-Pak | Tape and Reel Left | 3000 | AUIRLR3110ZTRL | |

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

| Symbol | Parameter | Max. | Units | |
|---|---|-------------------------|-------|--|
| I _D @ T _C = 25°C | Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) | 63⑨ | | |
| I _D @ T _C = 100°C | Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) | 459 | • | |
| I _D @ T _C = 25°C | Continuous Drain Current, V _{GS} @ 10V (Package Limited) | 42 | A | |
| I _{DM} | Pulsed Drain Current ① | 250 | 1 | |
| P _D @T _C = 25°C | Maximum Power Dissipation | 140 | W | |
| | Linear Derating Factor | 0.95 | W/°C | |
| V _{GS} | Gate-to-Source Voltage | ± 16 | V | |
| E _{AS} | Single Pulse Avalanche Energy (Thermally Limited) 2 | 110 | | |
| E _{AS} (Tested) | Single Pulse Avalanche Energy Tested Value 6 | 140 | mJ | |
| I _{AR} | Avalanche Current ① | See Fig.15,16, 12a, 12b | А | |
| E _{AR} | Repetitive Avalanche Energy S | | mJ | |
| TJ | Operating Junction and | -55 to + 175 | | |
| T _{STG} | Storage Temperature Range | | °C | |
| | Soldering Temperature, for 10 seconds (1.6mm from case) | 300 | | |

Thermal Resistance

| Symbol | Parameter | Тур. | Max. | Units |
|---------------------|-----------------------------------|------|------|-------|
| $R_{	ext{	heta}JC}$ | Junction-to-Case | | 1.05 | |
| $R_{	heta JA}$ | Junction-to-Ambient (PCB Mount) 🗇 | | 50 | °C/W |
| $R_{	heta JA}$ | Junction-to-Ambient | | 110 | |

HEXFET® is a registered trademark of Infineon.

*Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Тур. | Max. | Units | Conditions |
|-----------------------------------|--------------------------------------|------|-------|------|-------|---|
| V _{(BR)DSS} | Drain-to-Source Breakdown Voltage | 100 | | | V | V _{GS} = 0V, I _D = 250µA |
| $\Delta V_{(BR)DSS} / \Delta T_J$ | Breakdown Voltage Temp. Coefficient | | 0.077 | | V/°C | Reference to 25°C, I_D = 1mA |
| D | Statia Drain ta Sauraa On Dagiatanga | | 11 | 14 | | V _{GS} = 10V, I _D = 38A ③ |
| R _{DS(on)} | Static Drain-to-Source On-Resistance | | 12 | 16 | mΩ | V _{GS} = 4.5V, I _D = 32A ③ |
| V _{GS(th)} | Gate Threshold Voltage | 1.0 | | 2.5 | V | $V_{DS} = V_{GS}, I_{D} = 100 \mu A$ |
| gfs | Forward Trans conductance | 52 | | | S | V _{DS} = 25V, I _D = 38A |
| 1 | Drain to Source Lookage Current | | | 20 | μA | V _{DS} = 100 V, V _{GS} = 0V |
| IDSS | Drain-to-Source Leakage Current | | | 250 | μΑ | V _{DS} = 100V,V _{GS} = 0V,T _J =125°C |
| I _{GSS} | Gate-to-Source Forward Leakage | | | 200 | 5 | V _{GS} = 16V |
| | Gate-to-Source Reverse Leakage | | | -200 | 1 114 | V _{GS} = -16V |

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| Q _g | Total Gate Charge | 34 | 48 | | I _D = 38A |
|-----------------------|------------------------------|----------|----|----|---|
| Q _{gs} | Gate-to-Source Charge | 10 | | nC | $V_{\rm DS} = 50V$ |
| Q _{gd} | Gate-to-Drain Charge | 15 | | | V _{GS} = 4.5V3 |
| t _{d(on)} | Turn-On Delay Time | 24 | | | V _{DD} = 50V |
| t _r | Rise Time | 110 | | | I _D = 38A |
| t _{d(off)} | Turn-Off Delay Time | 33 | | ns | $R_G = 3.7\Omega$ |
| t _f | Fall Time | 48 | | | V _{GS} = 4.5V③ |
| L _D | Internal Drain Inductance | 4.5 | | nH | Between lead, 6mm (0.25in.) |
| L _S | Internal Source Inductance | 7.5 | | | from package and center of die contact |
| C _{iss} | Input Capacitance | 3980 | | | V _{GS} = 0V |
| C _{oss} | Output Capacitance | 310 | | | V _{DS} = 25V |
| C _{rss} | Reverse Transfer Capacitance | 130 | | pF | f = 1.0MHz |
| C _{oss} | Output Capacitance | 1820 | | рг | $V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$ |
| C _{oss} | Output Capacitance | 170 | |] | $V_{GS} = 0V, V_{DS} = 80V f = 1.0MHz$ |
| C _{oss eff.} | Effective Output Capacitance | 320 | | | V_{GS} = 0V, V_{DS} = 0V to 80V ④ |
| Diode Chara | cteristics | | | | |

Diode Characteristics

| | Parameter | Min. | Тур. | Max. | Units | Conditions |
|-----------------|---|-----------|--|------|-------|--|
| I _S | Continuous Source Current (Body Diode) | | | 63 | | MOSFET symbol showing the |
| I _{SM} | Pulsed Source Current (Body Diode) ① | | | 250 | | integral reverse |
| V_{SD} | Diode Forward Voltage | | | 1.3 | V | T _J = 25°C,I _S = 38A,V _{GS} = 0V ③ |
| t _{rr} | Reverse Recovery Time | | 34 | 51 | ns | T _J = 25°C ,I _F = 38A, V _{DD} = 50V |
| Q _{rr} | Reverse Recovery Charge | | 42 | 63 | nC | di/dt = 100A/µs③ |
| t _{on} | Forward Turn-On Time | Intrinsic | Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D) | | | |

Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

② Limited by T_{Jmax} , starting $T_J = 25^{\circ}$ C, L = 0.16mH, $R_G = 25\Omega$, $I_{AS} = 38A$, $V_{GS} = 10V$. Part not recommended for use above this value. Pulse width \leq 1.0ms; duty cycle \leq 2%. 3

④ Coss eff. is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS

S Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.

© This value determined from sample failure population. 100% tested to this value in production.

When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to Ø application note #AN-994.

8 R_e is measured at T_J approximately 90°C

③ Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 42A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.



TOP

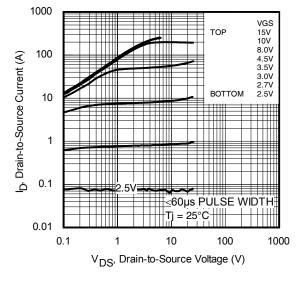
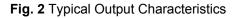


Fig. 1 Typical Output Characteristics

VGS 15V 10V 8.0V 4.5V 3.5V l_D, Drain-to-Source Current (A) 3.0V 2.7V 2.5V 100 BOTTOM 10 ⊴60µs PULSE WIDTH Tj = 175°C 1 0.1 100 1000 10 1 V_{DS} , Drain-to-Source Voltage (V)

1000



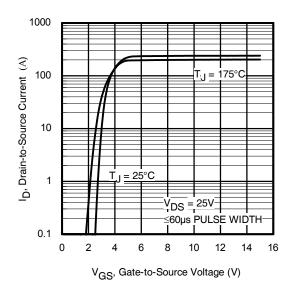


Fig. 3 Typical Transfer Characteristics

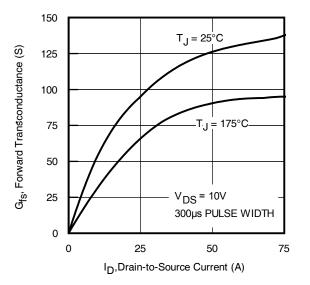
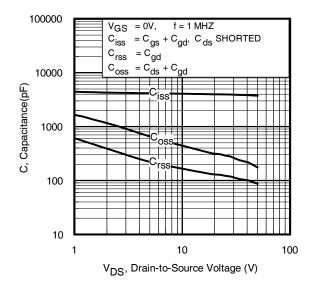
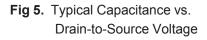


Fig. 4 Typical Forward Trans conductance Vs. Drain Current







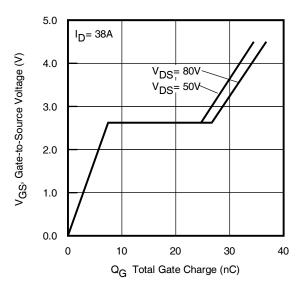
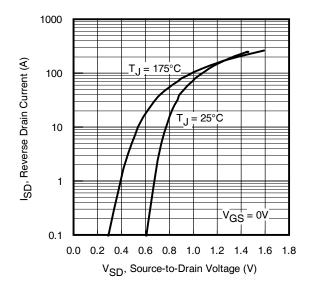
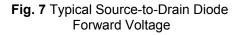


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage





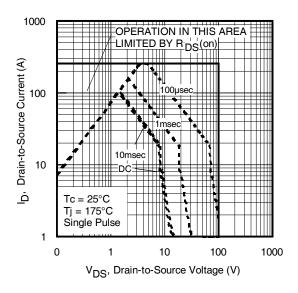
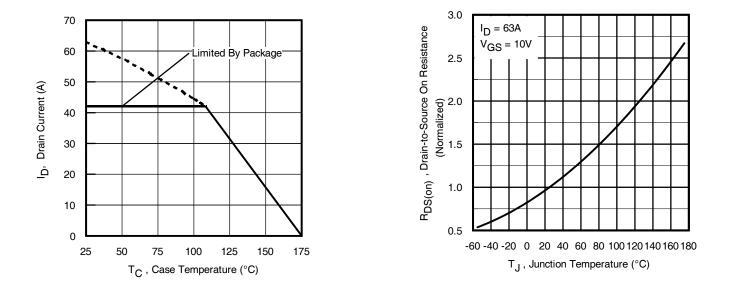
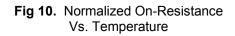


Fig 8. Maximum Safe Operating Area









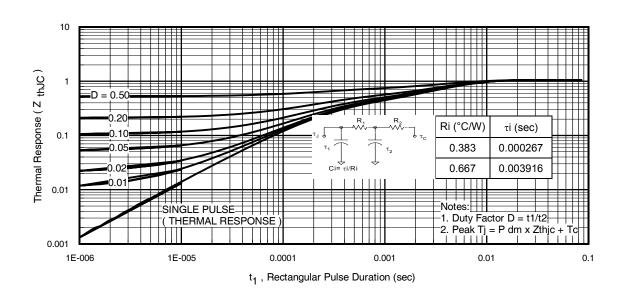


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

τ_J τ₁ Ci=

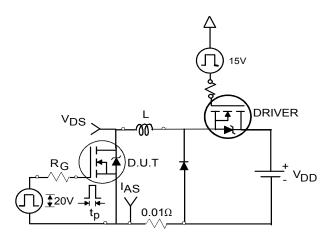


Fig 12a. Unclamped Inductive Test Circuit

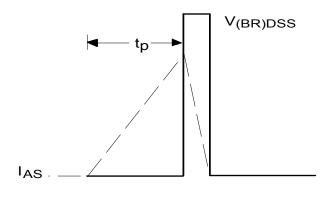


Fig 12b. Unclamped Inductive Waveforms

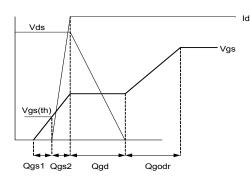


Fig 13a. Gate Charge Waveform

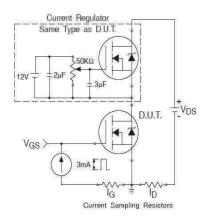
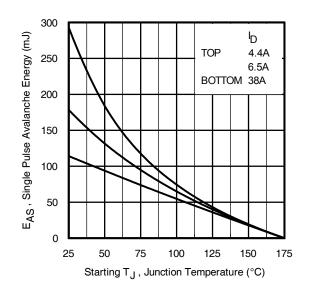
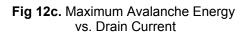


Fig 13b. Gate Charge Test Circuit





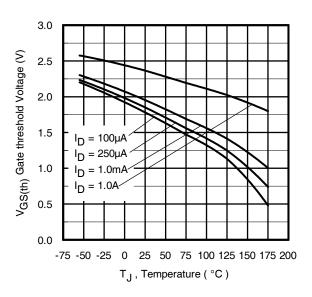


Fig 14. Threshold Voltage Vs. Temperature



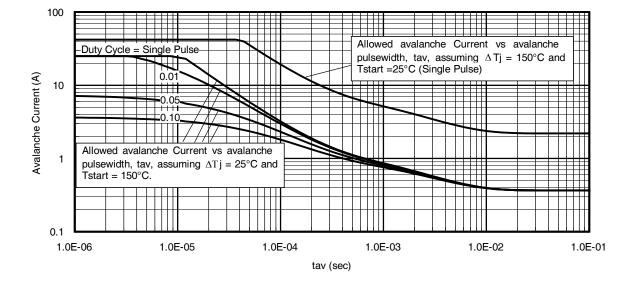


Fig 15. Typical Avalanche Current Vs. Pulse width

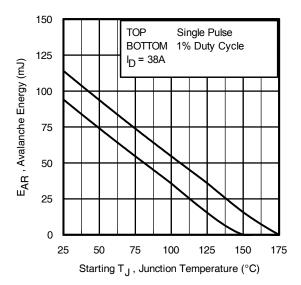


Fig 16. Maximum Avalanche Energy Vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 15, 16:

(For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} \textbf{P}_{D (ave)} &= 1/2 \; (\; \textbf{1.3} \cdot \textbf{BV} \cdot \textbf{I}_{av}) = \Delta T/ \; \textbf{Z}_{thJC} \\ \textbf{I}_{av} &= 2\Delta T/ \; [\textbf{1.3} \cdot \textbf{BV} \cdot \textbf{Z}_{th}] \\ \textbf{E}_{AS (AR)} &= \textbf{P}_{D (ave)} \cdot \textbf{t}_{av} \end{split}$$



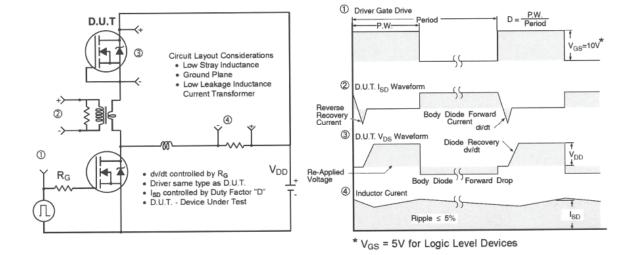


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

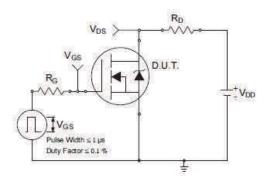


Fig 18a. Switching Time Test Circuit

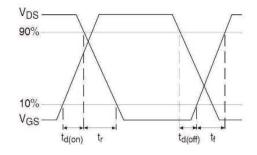
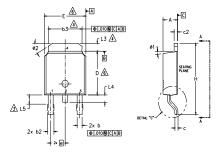


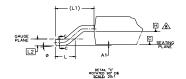
Fig 18b. Switching Time Waveforms

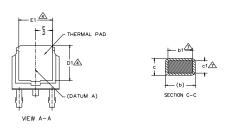


D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- A- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & 63 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- A- DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

| 9.– | OUTLINE | CONFORMS | то | JEDEC | OUTLINE | TO-252AA. | |
|-----|---------|----------|----|-------|---------|-----------|--|
| | | | | | | | |

| S Y M | | DIMENSIONS | | | | | |
|-------------|--------|-------------|------|------|-----------------------|--|--|
| B O | MILLIM | ETERS | INC | HES | N O T E S | | |
| 0 L | MIN. | MAX. | MIN. | MAX. | E S | | |
| Α | 2.18 | 2.39 | .086 | .094 | | | |
| A1 | - | 0.13 | - | .005 | | | |
| b | 0.64 | 0.89 | .025 | .035 | | | |
| b1 | 0.65 | 0.79 | .025 | .031 | 7 | | |
| b2 | 0.76 | 1.14 | .030 | .045 | | | |
| b3 | 4.95 | 5.46 | .195 | .215 | 4 | | |
| с | 0.46 | 0.61 | .018 | .024 | | | |
| c1 | 0.41 | 0.56 | .016 | .022 | 7 | | |
| c2 | 0.46 | 0.89 | .018 | .035 | | | |
| D | 5.97 | 6.22 | .235 | .245 | 6 | | |
| D1 | 5.21 | - | .205 | - | 4 | | |
| Е | 6.35 | 6.73 | .250 | .265 | 6 | | |
| E1 | 4.32 | - | .170 | - | 4 | | |
| е | 2.29 | BSC | .090 | BSC | | | |
| н | 9.40 | 10.41 | .370 | .410 | | | |
| L | 1.40 | 1.78 | .055 | .070 | | | |
| L1 | 2.74 | BSC | .108 | REF. | | | |
| L2 | 0.51 | BSC | .020 | BSC | | | |
| L3 | 0.89 | 1.27 | .035 | .050 | 4 | | |
| L4 | - | 1.02 | - | .040 | | | |
| L5 | 1.14 | 1.52 | .045 | .060 | 3 | | |
| ø | 0. | 10* | 0. | 10° | | | |
| ø1 | 0. | 15 ° | 0. | 15° | | | |
| ø2 | 25' | 35* | 25* | 35* | | | |

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

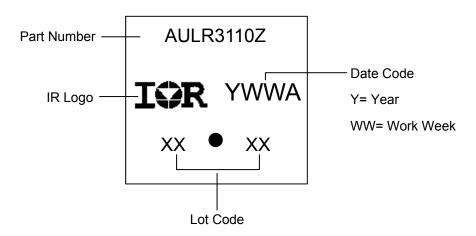
IGBT & CoPAK

1.- GATE

2.- COLLECTOR 3.- EMITTER

4.- COLLECTOR

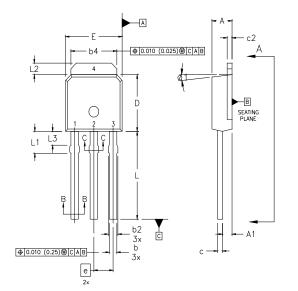
D-Pak (TO-252AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



I-Pak (TO-251AA) Package Outline (Dimensions are shown in millimeters (inches)



NOTES:

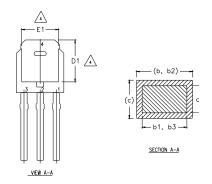
- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994. 1
- 2
- DIMENSION ARE SHOWN IN MILLIMETERS [INCHES]. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY. 3
- THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1. 4 LEAD DIMENSION UNCONTROLLED IN L3. 5
- 6 DIMENSION 61, 63 APPLY TO BASE METAL ONLY.
- OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA. 8
- CONTROLLING DIMENSION : INCHES.

LEAD ASSIGNMENTS

```
HEXFET
```

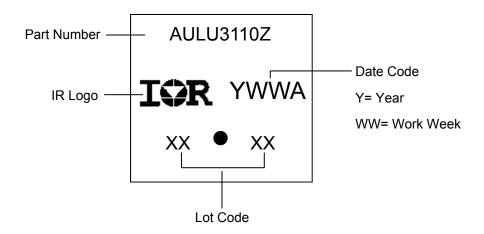
1.- GATE

- 2.- DRAIN 3.- SOURCE
- 4.- DRAIN



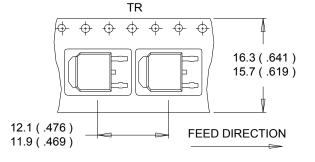
| SYMBOL | SYMBOL MILLIMETERS | | INC | | |
|--------|--------------------|------|-------|-------|-------|
| | Min. | MAX. | MIN. | MAX. | NOTES |
| A | 2.18 | 2.39 | 0.086 | .094 | |
| A1 | 0.89 | 1.14 | 0.035 | 0.045 | |
| b | 0.64 | 0.89 | 0.025 | 0.035 | |
| ь1 | 0.64 | 0.79 | 0.025 | 0.031 | 4 |
| b2 | 0.76 | 1.14 | 0.030 | 0.045 | |
| b3 | 0.76 | 1.04 | 0.030 | 0.041 | |
| b4 | 5.00 | 5.46 | 0.195 | 0.215 | 4 |
| с | 0.46 | 0.61 | 0.018 | 0.024 | |
| c1 | 0.41 | 0.56 | 0.016 | 0.022 | |
| c2 | .046 | 0.86 | 0.018 | 0.035 | |
| D | 5.97 | 6.22 | 0.235 | 0.245 | 3, 4 |
| D1 | 5.21 | - | 0.205 | - | 4 |
| E | 6.35 | 6.73 | 0.250 | 0.265 | 3, 4 |
| E1 | 4.32 | - | 0.170 | - | 4 |
| e | 2. | 29 | 0.090 | BSC | |
| L | 8.89 | 9.60 | 0.350 | 0.380 | |
| L1 | 1.91 | 2.29 | 0.075 | 0.090 | |
| L2 | 0.89 | 1.27 | 0.035 | 0.050 | 4 |
| L3 | 1.14 | 1.52 | 0.045 | 0.060 | 5 |
| ø1 | 0. | 15' | 0. | 15* | |
| | | | | | |
| | | | | | |
| | | | | | |
| | | | | | |

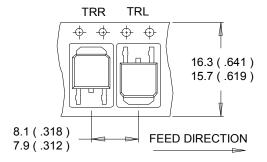
I-Pak (TO-251AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

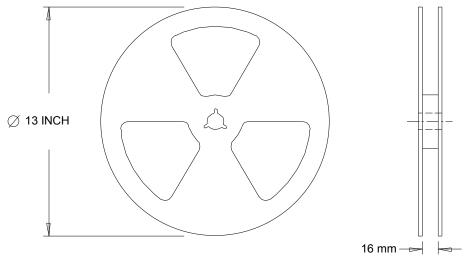
D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))





NOTES :

- 1. CONTROLLING DIMENSION : MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES : 1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

| | | Automotive | | | | | |
|---------------------|----------------------------|---|----------------------------------|--|--|--|--|
| | | | (per AEC-Q101) | | | | |
| Qualification Level | | Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level. | | | | | |
| Moioturo | Moisture Sensitivity Level | | MSL1 | | | | |
| woisture | | | WISE I | | | | |
| | | | Class M4 (+/- 700V) [†] | | | | |
| | Machine Model | AEC-Q101-002 | | | | | |
| | Liver an Dady Madal | Class H1C (+/- 2000V) [†] | | | | | |
| ESD | Human Body Model | AEC-Q101-001 | | | | | |
| | Charged Device Medal | Class C5 (+/- 2000V) [†] | | | | | |
| | Charged Device Model | AEC-Q101-005 | | | | | |
| RoHS Cor | RoHS Compliant | | Yes | | | | |

† Highest passing voltage.

Revision History

| Date | Comments |
|------------|--|
| 2/28/2014 | Added "Logic Level Gate Drive" bullet in the features section on page 1 |
| | Updated data sheet with new IR corporate template |
| 4/9/2014 | Updated package outline on page 9 & page 10 |
| | Updated qualification table- I-pak from "N/A" to "MSL1" on page 12 |
| 10/29/2015 | Updated datasheet with corporate template |
| | Corrected ordering table on page 1. |

Published by Infineon Technologies AG 81726 München, Germany © Infineon Technologies AG 2015 All Rights Reserved.

IMPORTANT NOTICE

The information given in this document shall in <u>no event</u> be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie"). With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office (<u>www.infineon.com</u>).

WARNINGS

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may <u>not</u> be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.